**HALOGEN** FREE



## 3 V to 28 V Input, 8 A, 12 A microBUCK® DC/DC Converter



## **LINKS TO ADDITIONAL RESOURCES**

**PowerCAD** Simulation





#### **DESCRIPTION**

The SiC43x are synchronous buck regulators with integrated high side and low side power MOSFETs. Its power stage is capable of supplying 12 A (SiC437) and 8 A (SiC438) continuous current at up to 1 MHz switching frequency. This regulator produces an adjustable output voltage down to 0.6 V from 3 V to 28 V input rail to accommodate a variety of applications, including computing, consumer electronics, telecom, and industrial.

SiC437's and SiC438's architecture delivers ultrafast transient response with minimum output capacitance and tight ripple regulation at very light load. The device is internally compensated and is stable with any capacitor. No external ESR network is required for loop stability purposes. The device also incorporates a power saving scheme that significantly increases light load efficiency.

The regulator family integrates a full protection feature set, including output overvoltage protection (OVP), cycle by cycle overcurrent protection (OCP) short circuit protection (SCP) and thermal shutdown (OTP). It also has UVLO and a user programmable soft start.

The SiC437 and SiC438 are available in lead (Pb)-free power enhanced MLP-44L package in 4 mm x 4 mm dimension.

## **APPLICATIONS**

- 5 V, 12 V, and 24 V input rail POLs
- Desktop, notebooks, server, and industrial computing
- · Industrial and automation

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· consumer electronics

## **FEATURES**

- Versatile
  - Operation from 3 V to 28 V input voltage
  - Adjustable output voltage down to 0.6 V
  - Scalable solution 8 A (SiC438), 12 A (SiC437), and 24 A (SiC431)
  - Output voltage tracking and sequencing with pre-bias start up
  - ± 1 % output voltage accuracy at -40 °C to +125 °C
- Highly efficient
  - 97 % peak efficiency
  - 1 µA supply current at shutdown
  - 50 µA operating current not switching
- Highly configurable
  - Four programmable switching frequencies available: 300 kHz, 500 kHz, 750 kHz, and 1 MHz
  - Adjustable soft start and adjustable current limit
  - Three modes of operation: forced continuous conduction, power save (SiC43xB, SiC43xD), or ultrasonic (SiC43xA, SiC43xC)
- · Robust and reliable
  - Cycle-by-cycle current limit
  - Output overvoltage protection
  - Output undervoltage / short circuit protection with auto
  - Power good flag and over temperature protection
- · Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

### TYPICAL APPLICATION CIRCUIT AND PACKAGE OPTIONS

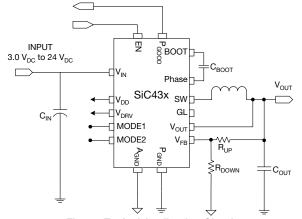


Fig. 1 - Typical Application Circuit

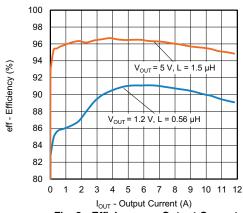


Fig. 2 - Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 500 kHz, Power Saving Mode)



## **PIN CONFIGURATION**

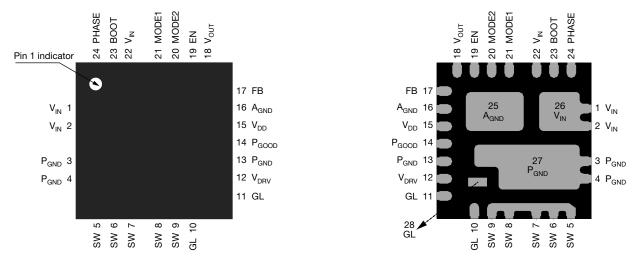


Fig. 3 - SiC43x Pin Configuration

PIN DESCRIP	<b>TION</b>	
PIN NUMBER	SYMBOL	DESCRIPTION
1, 2, 22, 26	V <sub>IN</sub>	Input voltage
3, 4, 13, 27	$P_{GND}$	Power signal return ground
5 to 9	SW	Switching node signal; output inductor connection point
10, 11, 28	GL	Low side power MOSFET gate signal
12	$V_{DRV}$	Supply voltage for internal gate driver. Connect a 2.2 µF decoupling capacitor to P <sub>GND</sub>
14	$P_{GOOD}$	Power good signal output; open drain
15	$V_{DD}$	Supply voltage for internal logic. Connect a 1 μF decoupling capacitor to A <sub>GND</sub>
16, 25	$A_{GND}$	Analog signal return ground
17	FB	Output voltage feedback pin; connect to V <sub>OUT</sub> through a resistor divider network.
18	V <sub>OUT</sub>	Output voltage sense pin
19	EN	Enable pin
20	MODE2	Soft start and current limit selection; connect a resistor to V <sub>DD</sub> or A <sub>GND</sub> per table 2
21	MODE1	Operating mode and switching frequency selection; connect a resistor to V <sub>DD</sub> or A <sub>GND</sub> per table 1
23	BOOT	Bootstrap pin; connect a capacitor to PHASE pin for HS power MOSFET gate voltage supply
24	PHASE	Switching node signal for bootstrap return path

ORDERING INFO	ORDERING INFORMATION							
PART NUMBER	PART MARKING	MAXIMUM CURRENT	$V_{DD}, V_{DRV}$	LIGHT LOAD MODE	OPERATING JUNCTION TEMPERATURE	PACKAGE		
SiC437AED-T1-GE3	SiC437A		Internal	Ultrasonic				
SiC437BED-T1-GE3	SiC437B	12 A	internai	Power saving				
SiC437CED-T1-GE3	SiC437C	12 A	E to cont	Ultrasonic				
SiC437DED-T1-GE3	SiC437D		External	Power saving	-40 °C to +125 °C	PowerPAK® MI P44-24I		
SiC438AED-T1-GE3	SiC438A		Internal	Ultrasonic	-40 C t0 +125 C	POWERPAN® MLP44-24L		
SiC438BED-T1-GE3	SiC438B	0.4	internai	Power saving				
SiC438CED-T1-GE3	SiC438C	8 A	Cytomal	Ultrasonic				
SiC438DED-T1-GE3	SiC438D		External	Power saving				



<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)							
ELECTRICAL PARAMETER	CONDITIONS	LIMITS	UNIT				
V <sub>IN</sub>	Reference to P <sub>GND</sub>	-0.3 to +30					
V <sub>OUT</sub>	Reference to P <sub>GND</sub>	-0.3 to +22					
V <sub>DD</sub> / V <sub>DRV</sub>	Reference to P <sub>GND</sub>	-0.3 to +6					
SW / PHASE	Reference to P <sub>GND</sub>	-0.3 to +30					
SW / PHASE (AC)	100 ns; reference to P <sub>GND</sub>	-8 to +35	V				
BOOT	Reference to P <sub>GND</sub>	-0.3 to +6					
BOOT to SW		-0.3 to +6					
A <sub>GND</sub> to P <sub>GND</sub>		-0.3 to +0.3					
EN	Reference to A <sub>GND</sub>	-0.3 to +30					
All other pins	Reference to A <sub>GND</sub>	-0.3 to +6					
Temperature							
Junction temperature	$T_J$	-40 to +150	္င				
Storage temperature	T <sub>STG</sub>	-65 to +150					
Power Dissipation							
Junction to ambient thermal impedance ( $R_{\theta JA}$ )		16	°C/W				
Junction to case thermal impedance ( $R_{\theta JC}$ )		2	C/VV				
Maximum power dissipation	Ambient temperature = 25 °C	7.75	W				
ESD Protection							
Electrostatic discharge protection	Human body model	4000	V				
Lieuti ostatic discriarge protection	Charged device model	1000	, v				

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating/conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS (all voltages referenced to GND = 0 V)					
PARAMETER	MIN.	TYP.	MAX.	UNIT	
Input voltage (V <sub>IN</sub> ) (SiC43xA, SiC43xB)	4.5	-	28		
Input voltage (V <sub>IN</sub> ) (SiC43xC, SiC43xD)	3	-	28		
Logic supply voltage, gate driver supply voltage (V <sub>DD</sub> , V <sub>DRV</sub> ) (SiC43xC, SiC43xD)	4.5	-	28	.,,	
Enable (EN)	0	-	28	V	
Input voltage (V <sub>IN</sub> ), external supply on V <sub>DD</sub> / V <sub>DRV</sub>	3	-	28		
Output voltage (V <sub>OUT</sub> )	0.6	-	0.9 x V <sub>IN</sub> and < 20 V		
Temperature					
Recommended ambient temperature -40 to +105					
Operating junction temperature		-40 to +125		°C	

PARAMETER	rions (V <sub>IN</sub> = 12 V, Y	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Power Supplies		1201001101110				
• •	V	V <sub>IN</sub> = 6 V to 28 V	4.75	_	E 05	
V <sub>DD</sub> supply	$V_{DD}$	(SiC43xA, SiC43xB)	4.75	5	5.25	V
V <sub>DD</sub> UVLO threshold, rising	$V_{DD\_UVLO}$		3.3	3.6	3.9	
V <sub>DD</sub> UVLO hysteresis	V <sub>DD_UVLO_HYST</sub>		-	300	-	mV
Maximum V <sub>DD</sub> current	I <sub>DD</sub>	V <sub>IN</sub> = 6 V to 28 V	3	-	-	mA
V <sub>DRV</sub> supply	$V_{DRV}$	V <sub>IN</sub> = 6 V to 28 V (SiC43xA, SiC43xB)	4.75	5	5.25	V
Maximum V <sub>DRV</sub> current	I <sub>DRV</sub>	V <sub>IN</sub> = 6 V to 28 V	50	-	-	mA
Input current	IV <sub>IN</sub>	Non-switching, V <sub>FB</sub> > 0.6 V	-	50	120	μΑ
Shutdown current	IV <sub>IN_SHDN</sub>	V <sub>EN</sub> = 0 V	ı	0.5	3	μΛ
Controller and Timing						
Feedback voltage	V	T <sub>J</sub> = 25 °C	597	600	603	m/V
reeuback voltage	$V_{FB}$	$T_J = -40  ^{\circ}\text{C to} + 125  ^{\circ}\text{C}  ^{(1)}$	594	600	606	111/ V
V <sub>FB</sub> input bias current	I <sub>FB</sub>		-	2	-	nA
Minimum on-time	t <sub>ON_MIN</sub> .		-	50	65	ns
t <sub>ON</sub> accuracy	t <sub>ON_ACCURACY</sub>		-10	-	10	%
On-time range	t <sub>ON_RANGE</sub>		65	-	2250	ns
Minimum fraguency akin made	f	Ultrasonic version (SiC43xA, SiC43xC)	20	-	30	IzI I=
Minimum frequency, skip mode	f <sub>SW_MIN</sub> .	Power save version (SiC43xB, SiC43xD)	0	-	-	- kHz
Minimum off-time	t <sub>OFF_MIN</sub> .		205	250	305	ns
Power MOSFETs (SiC437)						
High side on resistance	R <sub>ON_HS</sub>	V 5V T 05 %	-	10.1	-	
Low side on resistance	R <sub>ON_LS</sub>	$V_{DRV} = 5 \text{ V}, T_A = 25 \text{ °C}$		3.9	-	mΩ
Power MOSFETs (SiC438)						
High side on resistance	R <sub>ON_HS</sub>	V 5V T 05 %	-	10.1	-	
Low side on resistance	R <sub>ON_LS</sub>	$V_{DRV} = 5 \text{ V}, T_A = 25 \text{ °C}$	-	5.5	-	mΩ
Fault Protections						
Over current protection (inductor valley current)	I <sub>OCL_P</sub>	T <sub>J</sub> = -10 °C to +125 °C	-20	-	20	
Output OVP threshold	V <sub>OVP</sub>	V with warmant to 0 C V reference	-	20	-	%
Output UVP threshold	V <sub>UVP</sub>	V <sub>FB</sub> with respect to 0.6 V reference	-	-80	-	
0	T <sub>OTP_RISING</sub>	Rising temperature	-	150	-	00
Over temperature protection	T <sub>OTP_HYST</sub>	Hysteresis	-	25	-	°C
Power Good						
De la constanta de la Ultra de Ida	V <sub>FB_RISING_VTH_OV</sub>	V <sub>FB</sub> rising above 0.6 V reference	-	20	-	0/
Power good output threshold	V <sub>FB_FALLING_VTH_UV</sub>	V <sub>FB</sub> falling below 0.6 V reference	-	-10	-	%
Power good hysteresis	V <sub>FB_HYST</sub>		-	40	-	m۷
Power good on resistance	R <sub>ON_PGOOD</sub>		-	7.5	15	Ω
Power good delay time	t <sub>DLY_PGOOD</sub>		15	25	35	μs
EN / MODE / Ultrasonic Threshold	·					
EN logic high level	V <sub>EN_H</sub>		1.6	-	-	.,
EN logic low level	V <sub>EN_L</sub>		-	-	0.4	V
EN pull down resistance	R <sub>EN</sub>		-	5	-	MΩ
Switching Frequency				1		
		f <sub>sw</sub> = 300 kHz	-	51	55	
		f <sub>sw</sub> = 500 kHz	90	100	110	
MODE1 (switching frequency)	R <sub>MODE1</sub>	f <sub>sw</sub> = 750 kHz	180	200	220	kΩ
		f <sub>sw</sub> = 1000 kHz	450	499	550	1

ELECTRICAL SPECIFICATION	<b>ONS</b> (V <sub>IN</sub> = 12 V, '	V <sub>EN</sub> = 5 V, T <sub>J</sub> = -40 °C to +125 °C, ι	unless o	otherwi	se state	ed)		
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Soft Start								
Soft start time	+	Connect R <sub>MODE2</sub> between MODE2 and A <sub>GND</sub>		3	4.2	ms		
Soft start time	t <sub>ss</sub>	Connect R <sub>MODE2</sub> between MODE2 and V <sub>DD</sub>	3.6	6	8.4	IIIS		
Over Current Protection - SiC437	Over Current Protection - SiC437							
	R <sub>MODE2</sub>	I <sub>OCP</sub> = 18 A	450	499	550	kΩ		
MODE 2 (over current protection)		I <sub>OCP</sub> = 14 A	180	200	220			
WODE 2 (over current protection)		I <sub>OCP</sub> = 9.7 A	90	100	110			
		I <sub>OCP</sub> = 5.4 A	-	51	55			
Over Current Protection - SiC438								
		I <sub>OCP</sub> = 12 A	450	499	550			
MODE 2 (over current protection)	D	I <sub>OCP</sub> = 9.3 A	180	200	220	kΩ		
WODE 2 (over current protection)	R <sub>MODE2</sub>	I <sub>OCP</sub> = 6.5 A	90	100	110	NS 2		
		I <sub>OCP</sub> = 3.6 A	=.	51	55			

#### Note

## **FUNCTIONAL BLOCK DIAGRAM**

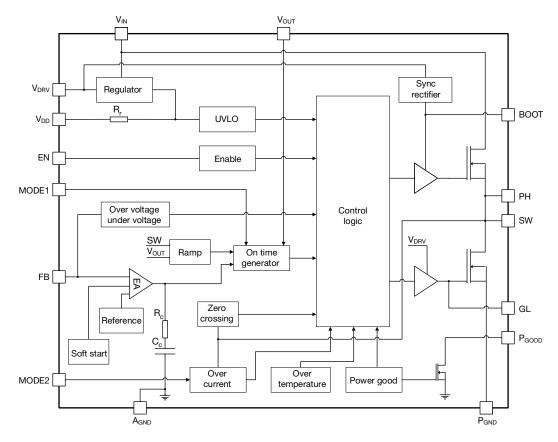


Fig. 4 - SiC43x Functional Block Diagram

<sup>(1)</sup> Guaranteed by design





## **OPERATIONAL DESCRIPTION**

#### **Device Overview**

The SiC43x is high efficiency synchronous buck regulators capable of delivering up to 8 A (SiC438) and 12 A (SiC437) continuous current. The device has user programmable switching frequency of 300 kHz, 500 kHz, 750 kHz, and 1 MHz. The control scheme delivers fast transient response and minimizes the number of external components. Thanks to the internal ramp information, no high ESR output bulk or virtual ESR network is required for the loop stability. This device also incorporates a power saving feature that enables diode emulation mode and frequency fold back as the load decreases.

SiC43x has a full set of protection and monitoring features:

- Over current protection in pulse-by-pulse mode
- · Output over voltage protection
- Output under voltage protection with device latch
- Over temperature protection with hysteresis
- · Dedicated enable pin for easy power sequencing
- Power good open drain output

This device is available in MLP44-24L package to deliver high power density and minimize PCB area.

## **Power Stage**

SiC43x integrates a high performance power stage with a low on resistance and gate charge, high side and low side MOSFETs. The MOSFETs are optimized to achieve up to 97 % efficiency.

The input voltage ( $V_{IN}$ ) can go up to 28 V and down to as low as 3 V for power conversion. For input voltages ( $V_{IN}$ ) below 4.5 V an external  $V_{DD}$  and  $V_{DRV}$  supply is required (SiC43xC, SiC43xD). For input voltages ( $V_{IN}$ ) above 4.5 V only a single input supply is required (SiC43xA, SiC43xB).

## **Control Mechanism**

SiC43x employs an advanced voltage - mode COT control mechanism. During steady-state operation, feedback voltage ( $V_{FB}$ ) is compared with internal reference (0.6 V typ.) and the amplified error signal ( $V_{COMP}$ ) is generated at the internal comp node. An internally generated ramp signal and  $V_{COMP}$  feed into a comparator. Once  $V_{RAMP}$  crosses  $V_{COMP}$ , an on-time pulse is generated for a fixed time. During the on-time pulse, the high side MOSFET will be turned on. Once the on-time pulse expires, the low side MOSFET will be turned on after a dead time period. The low side MOSFET will stay on for a minimum duration equal to the minimum off-time ( $t_{OFF\_MIN}$ ) and remains on until  $V_{RAM}$ P crosses  $V_{COMP}$ . The cycle is then repeated.

Fig. 5 illustrates the basic block diagram for VM-COT architecture. In this architecture the following is achieved:

- The reference of a basic ripple control regulator is replaced with a high again error amplifier loop
- This establishes two parallel voltage regulating feedback paths, a fast and slow path
- Fast path is the ripple injection which ensures rapid correction of the transient perturbation

 Slow path is the error amplifier loop which ensures the DC component of the output voltage follows the internal accurate reference voltage

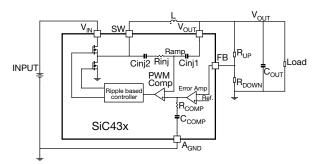


Fig. 5 - VM-COT Block Diagram

All components for RAMP signal generation and error amplifier compensation required for the control loop are internal to the IC, see Fig. 5. In order for the device to cover a wide range of VOUT operation, the internal RAMP signal components (R<sub>X</sub>, C<sub>X</sub>, C<sub>Y</sub>) are automatically selected depending on the V<sub>OUT</sub> voltage and switching frequency. This method allows the RAMP amplitude to remain constant throughout the V<sub>OUT</sub> voltage range, achieving low jitter and fast transient Response. The error amplifier internal compensation consists of a resistor in series with a capacitor (R<sub>COMP</sub>, C<sub>COMP</sub>).

Fig. 6 demonstrates the basic operational waveforms:

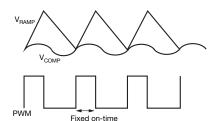


Fig. 6 - VM-COT Operational Principle

### **Light Load Condition**

To improve efficiency at light-load condition, SiC437, SiC438 provide a set of innovative implementations to eliminate LS recirculating current and switching losses. The internal zero crossing detector monitors SW node voltage to determine when inductor current starts to flow negatively. In power saving mode, as soon as inductor valley current crosses zero, the device deploys diode emulation mode by turning off low side MOSFET. If load further decreases, switching frequency is reduced proportional to load condition to save switching losses while keeping output ripple within tolerance. The switching frequency is set by the controller to maintain regulation. In the standard power save mode, there is no minimum switching frequency (SiC43xB, SiC43xD). For SiC43xA, SiC43xC, the minimum switching frequency that the regulator will reduce to is > 20 kHz as the part avoids switching frequencies in the audible range. This light load mode implementation is called ultrasonic mode.



# MODE SETTING, OVER CURRENT PROTECTION, SWITCHING FREQUENCY, AND SOFT START SELECTION

The SiC437, SiC438 has a low pin count, minimal external components, and offers the user flexibility to choose soft start times, current limit settings, switching frequencies and to enable or disable the light load mode. Two MODE pins,

MODE1 and MODE2, are user programmable by connecting a resistor from MODEx to  $V_{DD}$  or  $A_{GND}$ , allowing the user to choose various operating modes. This is best explained in the tables below.

TABLE 1 - MODE1 CON	IFIGURATION SETTINGS		
OPERATION	CONNECTION	f <sub>SWITCH</sub> (kHz)	R <sub>MODE1</sub> (kΩ)
		300	51
Skip	+o A	500	100
ЭКІР	to A <sub>GND</sub>	750	200
		1000	499
		300	51
Forced CCM	L. M	500	100
	to V <sub>DD</sub>	750	200
		1000	499

TABLE 2 - MODE2 CONI	FIGURATION SETTING	S	
SOFT-START TIME	CONNECTION	I <sub>LIMIT</sub> (%)	R <sub>MODE2</sub> (kΩ)
		30	51
		54	100
3 ms	to A <sub>GND</sub>	78	200
		100 % (18 A on SiC437) 100 % (12 A on SiC438)	499
		30	51
		54	100
6 ms	to $V_{DD}$	78	200
		100 % (18 A on SiC437) 100 % (12 A on SiC438)	499

## **OUTPUT MONITORING AND PROTECTION FEATURES**

## **Output Overcurrent Protection (OCP)**

SiC437, SiC438 has pulse-by-pulse over current limit control. The inductor current is monitored during low side MOSFET conduction time through RDS(on) sensing. After a pre-defined blanking time, the inductor current is compared with an internal OCP threshold. If inductor current is higher than OCP threshold, high side MOSFET is kept off until the inductor current falls below OCP threshold.

OCP is enabled immediately after  $\ensuremath{V_{DD}}$  passes UVLO rising threshold.

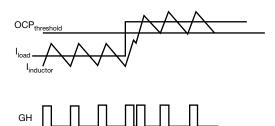


Fig. 7 - Over-Current Protection Illustration



## **Output Undervoltage Protection (UVP)**

UVP is implemented by monitoring the FB pin. If the voltage level at FB drops below 0.12 V for more than 25  $\mu$ s, a UVP event is recognized and both high side and low side MOSFETs are turned off. After a duration equivalent to 20 soft start periods, the IC attempts to re-start. If the fault condition still exists, the above cycle will be repeated.

UVP is active after the completion of soft start sequence.

#### **Output Overvoltage Protection (OVP)**

OVP is implemented by monitoring the FB pin. If the voltage level at FB rising above 0.72 V, a OVP event is recognized and both high side and low side MOSFETs are turned off. Normal operation is resumed once FB voltage drop below 0.68 V.

OOVP is active after V<sub>DD</sub> passes UVLO rising threshold.

## **Over-Temperature Protection (OTP)**

OTP is implemented by monitoring the junction temperature. If the junction temperature rises above 150 °C, a OTP event is recognized and both high side and low MOSFETs are turned off. After the junction temperature falls below 125 °C (25 °C hysteresis), the device restarts by initiating a soft start sequence.

#### Sequencing of Input / Output Supplies

SiC437, SiC438 have no sequencing requirements on its supplies or enables ( $V_{IN},\,V_{DD},\,V_{DRV},\,EN$ ).

## Enable

The SiC437, SiC438 have an enable pin to turn the part on and off.

Driving the pin high enables the device, while driving the pin low disables the device.

The EN pin is internally pulled to  $A_{GND}$  by a 5 M $\Omega$  resistor to prevent unwanted turn on due to a floating GPIO.

### Pre-Bias Start-Up

In case of pre-bias startup, output is monitored through FB pin. If the sensed voltage on FB is higher than the internal reference ramp value, control logic prevents high side and low side MOSFETs from switching to avoid negative output voltage spike and excessive current sinking through low side MOSFET.

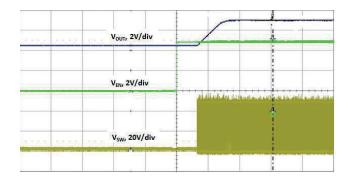


Fig. 8 - Pre-Bias Start-Up

#### **Power Good**

SiC437, SiC438 power good is an open-drain output. Pull  $P_{GOOD}$  pin high through a > 10  $k\Omega$  resistor to use this signal. Power good window is shown in the below diagram. If voltage on FB pin is out of this window,  $P_{GOOD}$  signal is de-asserted by pulling down to  $A_{GND}.$  To prevent false triggering during transient events,  $P_{GOOD}$  has a 25  $\mu s$  blanking time.

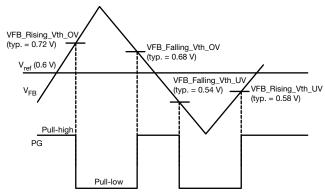


Fig. 9 - P<sub>GOOD</sub> Window Diagram



 $(V_{IN} = 12 \text{ V}, V_{OUT} = 1.2 \text{ V}, f_{sw} = 500 \text{ kHz}, C_{OUT} = 47 \mu\text{F x 7}, C_{IN} = 10 \mu\text{F x 6}, unless otherwise noted)$ 

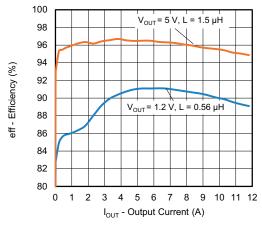


Fig. 10 - SiC437 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 500 kHz, Full Load)

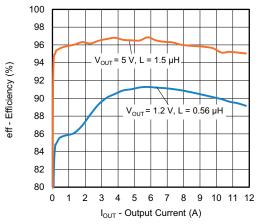


Fig. 11 - SiC437 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 500 kHz, Ultrasonic Mode, Full Load)

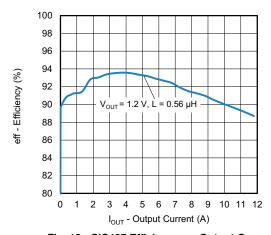


Fig. 12 - SiC437 Efficiency vs. Output Current (V<sub>IN</sub> = 5 V, f<sub>sw</sub> = 500 kHz, Full Load)

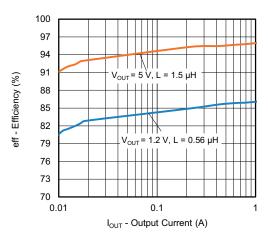


Fig. 13 - SiC437 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 500 kHz, Light Load)

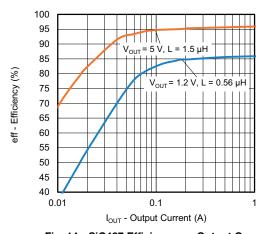


Fig. 14 - SiC437 Efficiency vs. Output Current ( $V_{IN}=12~V,\,f_{sw}=500~kHz,\,Ultrasonic\,Mode,\,Light\,Load)$ 

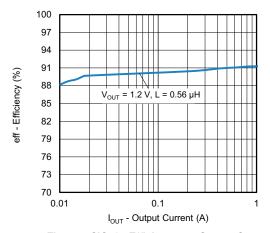


Fig. 15 - SiC437 Efficiency vs. Output Current (V<sub>IN</sub> = 5 V, f<sub>sw</sub> = 500 kHz, Light Load)



( $V_{IN}$  = 12 V,  $V_{OUT}$  = 1.2 V,  $f_{sw}$  = 500 kHz,  $C_{OUT}$  = 47  $\mu$ F x 7,  $C_{IN}$  = 10  $\mu$ F x 6, unless otherwise noted)

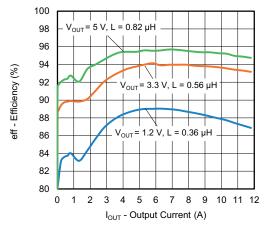


Fig. 16 - SIC437 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 1 MHz, Full Load)

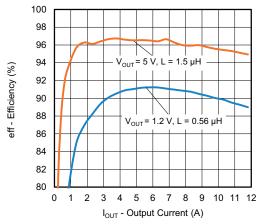


Fig. 17 - SiC437 Efficiency vs. Output Current ( $V_{IN}$  = 12 V,  $f_{sw}$  = 500 kHz, FCCM, Full Load)

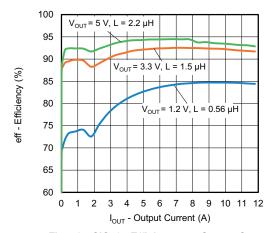


Fig. 18 - SiC437 Efficiency vs. Output Current  $(V_{IN} = 24 \text{ V}, f_{sw} = 500 \text{ kHz}, \text{Full Load})$ 

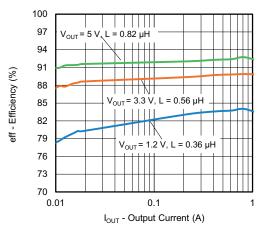


Fig. 19 - SiC437 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 1 MHz, Light Load)

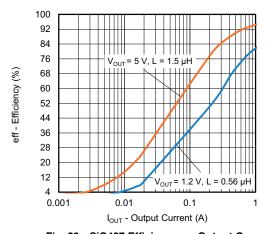


Fig. 20 - SiC437 Efficiency vs. Output Current ( $V_{IN}$  = 12 V,  $f_{sw}$  = 500 kHz, FCCM, Light Load)

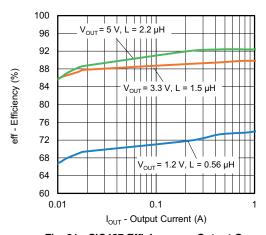


Fig. 21 - SiC437 Efficiency vs. Output Current ( $V_{\rm IN}$  = 24 V,  $f_{\rm sw}$  = 500 kHz, Light Load)



 $(V_{IN} = 12 \text{ V}, V_{OUT} = 1.2 \text{ V}, f_{sw} = 500 \text{ kHz}, C_{OUT} = 47 \mu F \text{ x} 7, C_{IN} = 10 \mu F \text{ x} 6, unless otherwise noted)$ 

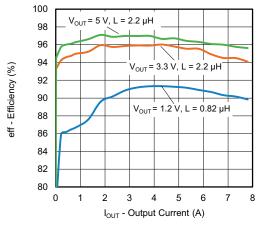


Fig. 22 - SiC438 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 500 kHz, Full Load)

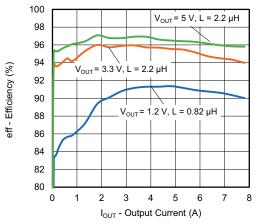


Fig. 23 - SiC438 Efficiency vs. Output Current ( $V_{\rm IN}$  = 12 V,  $f_{\rm sw}$  = 500 kHz, Ultrasonic Mode, Full Load)

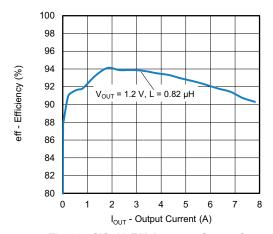


Fig. 24 - SiC438 Efficiency vs. Output Current (V<sub>IN</sub> = 5 V, f<sub>sw</sub> = 500 kHz, Full Load)

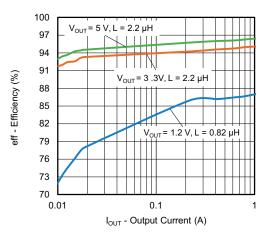


Fig. 25 - SiC438 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 500 kHz, Light Load)

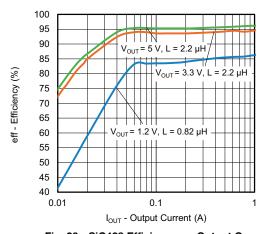


Fig. 26 - SiC438 Efficiency vs. Output Current ( $V_{IN}=12~V,\,f_{sw}=500~kHz,\,Ultrasonic\,Mode,\,Light\,Load)$ 

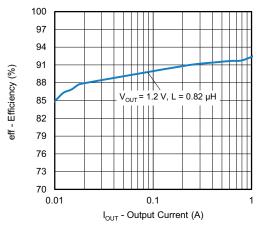


Fig. 27 - SiC438 Efficiency vs. Output Current ( $V_{IN} = 5 \text{ V}, f_{sw} = 500 \text{ kHz}, \text{Light Load}$ )



 $(V_{IN} = 12 \text{ V}, V_{OUT} = 1.2 \text{ V}, f_{sw} = 500 \text{ kHz}, C_{OUT} = 47 \mu\text{F x 7}, C_{IN} = 10 \mu\text{F x 6}, unless otherwise noted)$ 

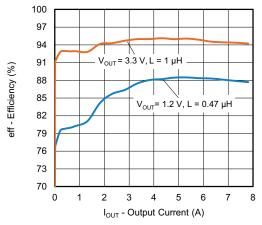


Fig. 28 - SiC438 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 1 MHz, Full Load)

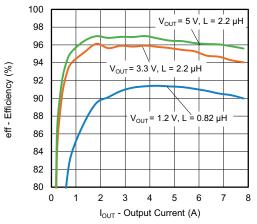


Fig. 29 - SiC438 Efficiency vs. Output Current ( $V_{IN}$  = 12 V,  $f_{sw}$  = 500 kHz, FCCM, Full Load)

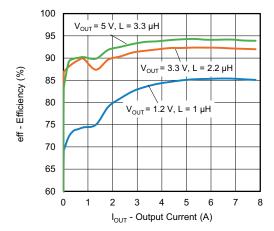


Fig. 30 - SiC438 Efficiency vs. Output Current ( $V_{IN} = 24 \text{ V}, f_{sw} = 500 \text{ kHz}, \text{Full Load}$ )

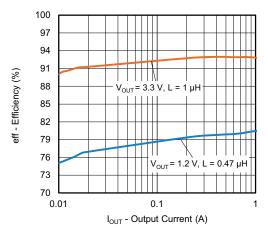


Fig. 31 - SiC438 Efficiency vs. Output Current (V<sub>IN</sub> = 12 V, f<sub>sw</sub> = 1 MHz, Light Load)

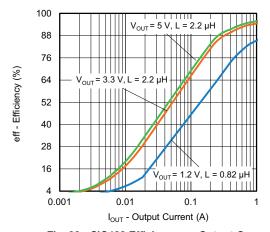


Fig. 32 - SiC438 Efficiency vs. Output Current ( $V_{IN}$  = 12 V,  $f_{sw}$  = 500 kHz, FCCM, Light Load)

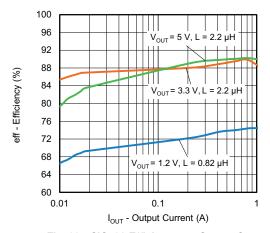


Fig. 33 - SiC438 Efficiency vs. Output Current ( $V_{\rm IN}$  = 24 V,  $f_{\rm sw}$  = 500 kHz, Light Load)



( $V_{IN}$  = 12 V,  $V_{OUT}$  = 1.2 V,  $f_{sw}$  = 500 kHz,  $C_{OUT}$  = 47  $\mu$ F x 7,  $C_{IN}$  = 10  $\mu$ F x 6, unless otherwise noted)

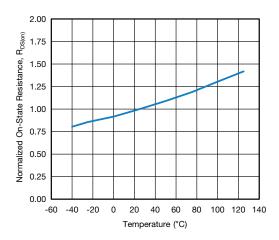


Fig. 34 - On-Resistance vs. Junction Temperature

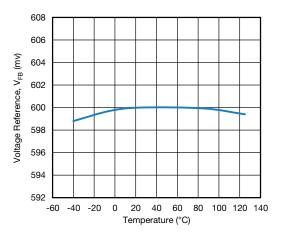


Fig. 35 - Voltage reference vs. Junction Temperature

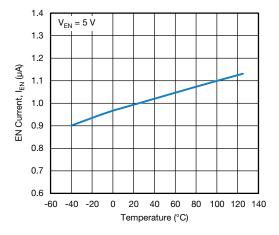


Fig. 36 - EN Current vs. Junction Temperature

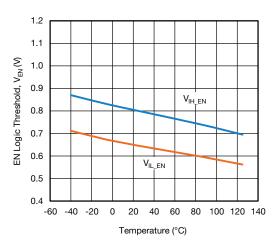


Fig. 37 - EN Logic Threshold vs. Junction Temperature

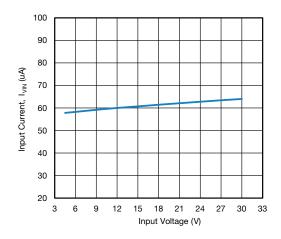


Fig. 38 - Input Current vs. Input Voltage

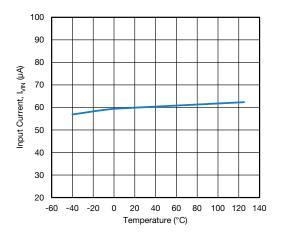


Fig. 39 - Input Current vs. Junction Temperature



 $(V_{IN} = 12 \text{ V}, V_{OUT} = 1.2 \text{ V}, f_{sw} = 500 \text{ kHz}, C_{OUT} = 47 \mu\text{F x 7}, C_{IN} = 10 \mu\text{F x 6}, unless otherwise noted)$ 

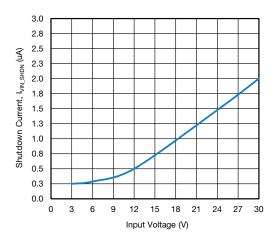


Fig. 40 - Shutdown Current vs. Input Voltage

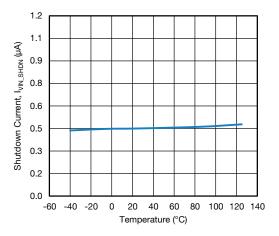


Fig. 41 - Shutdown Current vs. Junction Temperature

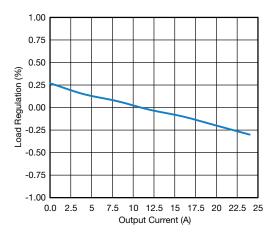


Fig. 42 - Load Regulation vs. Output Current

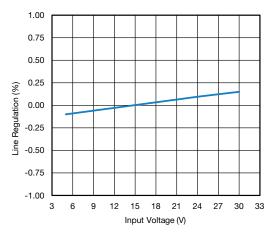


Fig. 43 - Line Regulation vs. Input Voltage

( $V_{IN}$  = 12 V,  $V_{OUT}$  = 1.2 V,  $f_{sw}$  = 500 kHz,  $C_{OUT}$  = 47  $\mu$ F x 7,  $C_{IN}$  = 10  $\mu$ F x 6, unless otherwise noted)

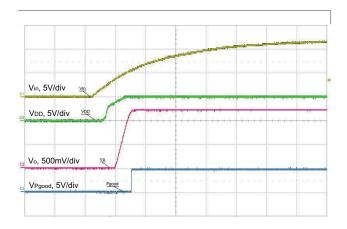


Fig. 44 - Startup with V<sub>IN</sub>, t = 5 ms/div

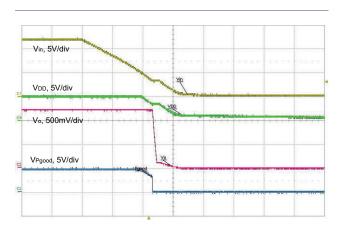


Fig. 47 - Shut down with V<sub>IN</sub>, t = 20 ms/div

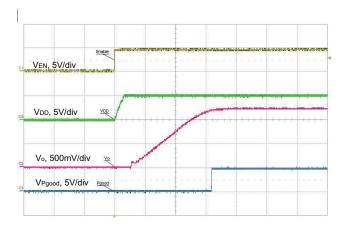


Fig. 45 - Startup with EN, t = 1 ms/div

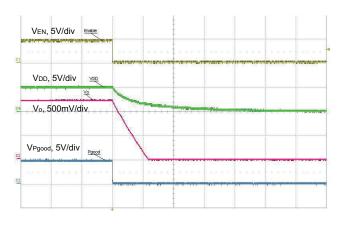


Fig. 48 - Shut down with EN, t = 100 ms/div

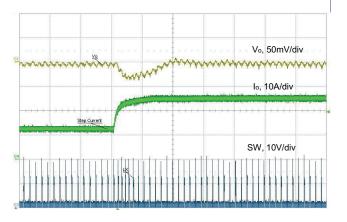


Fig. 46 - Load Step, 6 A to 12 A, 1 A/ $\mu$ s, t = 10  $\mu$ s/div

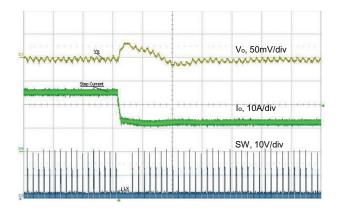


Fig. 49 - Load Release, 12 A to 6 A, 1 A/ $\mu$ s, t = 10  $\mu$ s/div



 $(V_{IN} = 12 \text{ V}, V_{OUT} = 1.2 \text{ V}, f_{sw} = 500 \text{ kHz}, C_{OUT} = 47 \mu\text{F x 7}, C_{IN} = 10 \mu\text{F x 6}, unless otherwise noted)$ 

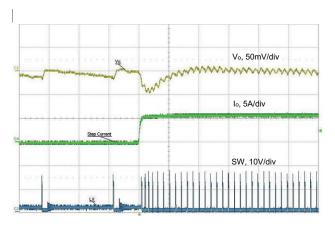


Fig. 50 - Load Step, 0.1 A to 6 A, 1 A/μs, t = 10 μs/div Skip Mode Enabled

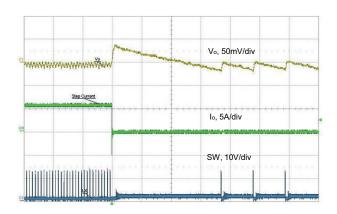


Fig. 53 - Load Release, 6 A to 0.1 A, 1 A/μs, t = 20 μs/div Skip Mode Enabled

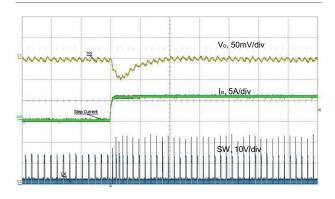


Fig. 51 - Load Step, 0.1 A to 6 A, 1 A/µs, t = 10 µs/div Forced Continuous Conduction Mode

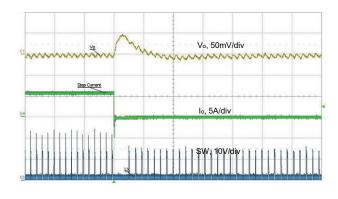


Fig. 54 - Load Release, 6 A to 0.1 A, 1 A/μs, t = 10 μs/div Forced Continuous Conduction Mode

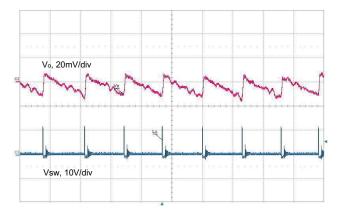


Fig. 52 - Output Ripple, 0.1 A, t = 20 μs/divSkip Mode Enabled

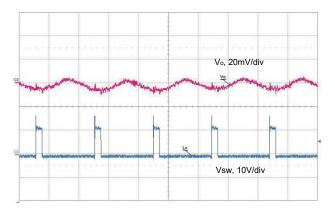


Fig. 55 - Output Ripple, 6 A, t = 1 μs/div Forced Continuous Conduction Mode



( $V_{IN}$  = 12 V,  $V_{OUT}$  = 1.2 V,  $f_{sw}$  = 500 kHz,  $C_{OUT}$  = 47  $\mu$ F x 7,  $C_{IN}$  = 10  $\mu$ F x 6, unless otherwise noted)

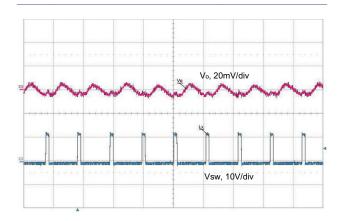


Fig. 56 - Output Ripple, 0.1 A, t = 2 μs/div Forced Continuous Conduction Mode

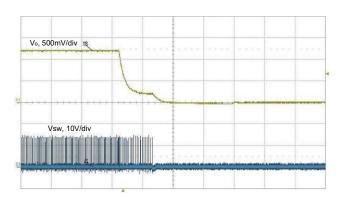


Fig. 58 - Output Undervoltage Protection Behavior, t = 50 μs/div

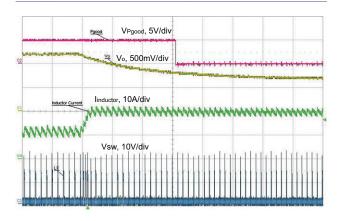


Fig. 57 - Overcurrent Protection Behavior,  $t = 10 \mu s/div$ 

## **EXAMPLE SCHEMATIC**

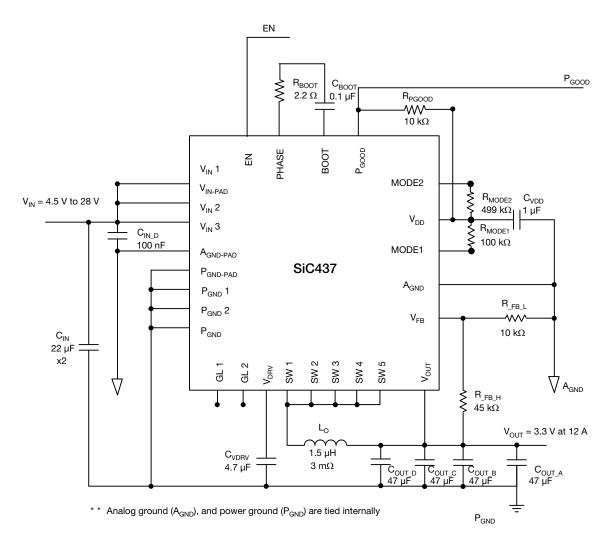


Fig. 59 - SiC437 configured for 4.5 V to 28 V Input, 3.3 V Output at 12 A, 500 kHz Operating Frequency, Continuous Mode enabled, all Ceramic Output Capacitance Design

#### **EXTERNAL COMPONENT SELECTION FOR THE SIC43X**

This section explains external component selection for the SiC43x family of regulators. Component reference designators in any equation refer to the schematic shown in Fig. 59.

See PowerCAD online design center to simplify external component calculations.

#### **Output Voltage Adjustment**

If a different output voltage is needed, simply change the value of V<sub>OUT</sub> and solve for R<sub>FB\_H</sub> based on the following formula:

$$R_{\_FB\_H} = \frac{R_{\_FB\_L}(V_{OUT} - V_{FB})}{V_{FB}}$$

Where  $V_{FB}$  is 0.6 V for the SiC43X.  $R_{FB\_L}$  should be a maximum of 10 k $\Omega$  to prevent  $V_{OUT}$  from drifting at no load.

#### **Inductor Selection**

In order to determine the inductance, the ripple current must first be defined. Low inductor values allow for the use of smaller package sizes but create higher ripple current which can reduce efficiency. Higher inductor values will reduce the ripple current and, for a given DC resistance, are more efficient. However, larger inductance translates directly into larger packages and higher cost. Cost, size, output ripple, and efficiency are all used in the selection process.

The ripple current will also set the boundary for power save operation. The SiC431 will typically enter power save mode when the load current decreases to 1/2 of the ripple current. For example, if ripple current is 4 A, power save operation will be active for loads less than 2 A. If ripple current is set at 40 % of maximum load current, power save will typically start at a load which is 20 % of maximum current.

The inductor value is typically selected to provide ripple current of 25 % to 50 % of the maximum load current. This provides an optimal trade-off between cost, efficiency, and transient performance. During the on-time, voltage across the inductor is  $(V_{IN} - V_{OUT})$ . The equation for determining inductance is shown below.

$$L_{O} = \frac{(V_{IN} - V_{OUT}) \times D}{K \times I_{OUT MAX} \times f_{SW}}$$

where, K is the maximum percentage of ripple current, D is the duty cycle,  $I_{OUT\_MAX}$  is the maximum load current and  $f_{SW}$  is the switching frequency.

#### **Capacitor Selection**

For instance, the design goal for output voltage ripple is 3 % (45 mV for  $V_{OUT}$  = 1.5 V) with ripple current of 4.43 A. The maximum ESR value allowed is shown by the following equation.

The output capacitors are chosen based upon required ESR and capacitance. The maximum ESR requirement is controlled by the output ripple requirement and the DC tolerance. The output voltage has a DC value that is equal to the valley of the output ripple plus 1/2 of the peak-to-peak ripple. A change in the output ripple voltage will lead to a change in DC voltage at the output.

$$ESR_{MAX.} = \frac{V_{RIPPLE}}{I_{RIPPLE}} = \frac{45 \text{ mV}}{4.43 \text{ A}}$$

$$ESR_{MAX} = 10.2 \text{ m}\Omega$$

The output capacitance is usually chosen to meet transient requirements. A worst-case load release (from maximum load to no load) at the moment of peak inductor current, determines the required capacitance. If the load release is instantaneous (maximum load to no load in less than 1  $\mu$ s) the output capacitor must absorb all the inductor's stored energy. The output capacitor can be calculated according to the following equation.

$$C_{OUT\_MIN.} = \frac{L_O(I_{OUT} + 0.5 \times I_{RIPPLE_{MAX.}})^2}{V_{PK}^2 - V_{OUT}^2}$$

Where  $I_{OUT}$  is the output current,  $I_{RIPPLE\_MAX.}$  is the maximum ripple current,  $V_{PK}$  is the peak  $V_{OUT}$  during load release,  $V_{OUT}$  is the output voltage.

The duration of the load release is determined by  $V_{OUT}$  and the inductor. During load release, the voltage across the inductor is approximately - $V_{OUT}$ , causing a down-slope or falling di/dt in the inductor. If the di/dt of the load is not much larger than di/dt of the inductor, then the inductor current will tend to track the falling load current. This will reduce the excess inductive energy that must be absorbed by the output capacitor; therefore a smaller capacitance can be used.

Under this circumstance, the following equation can be used to calculate the needed capacitance for a given rate of load release (dil OAD/dt).

$$C_{OUT} = \frac{\frac{L \times I_{PK}^2}{V_{OUT}^2} - (I_{PK} \times I_{RELEASE}) \times \frac{dT}{di_{LOAD}}}{2(V_{PK} - V_{OUT})}$$

$$I_{PK} = I_{RELEASE} + \left(\frac{1}{2} \times I_{RIPPLE_{MAX}}\right)$$

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Where  $I_{PK}$  is the peak inductor current,  $I_{RIPPLE\_MAX}$  is the maximum peak to peak inductor current,  $I_{RELEASE}$  is the maximum load release current,  $V_{PK}$  is the peak  $V_{OUT}$  during load release,  $dI_{LOAD}$ /dt is the rate of load release.

If the load step does not meet the requirement, increasing the crossover frequency can help by adding feed forward capacitor ( $C_{FF}$ ) in parallel to the upper feedback resistor to generate another zero and pole. Placing the geometrical mean of this pole and zero around the crossover frequency will result in faster transient response.  $f_Z$  and  $f_P$  are the generated zero and pole, see equations below.

$$f_Z = \frac{1}{2\pi \times R_{FB1} \times C_{FF}}$$

$$f_{P} = \frac{1}{2\pi \ x \ (R_{FB1} \ /\!/ \ R_{FB2}) \ x \ C_{FF}}$$

Where  $R_{FB1}$  is the upper feedback resistor,  $R_{FB2}$  is the lower feedback resistor  $C_{FF}$  is the feed forward capacitor,  $f_Z$  is the zero from feed forward capacitor,  $f_P$  is the pole frequency generated from the feed forward capacitor.

A calculator is available to assist user to obtain the value of the feed forward capacitance value.

From the calculator, obtain the crossover frequency ( $f_C$ ). Use the equation below for the calculation of the feed forward capacitance value.

$$f_{C} = \sqrt{(f_{Z} \times f_{P})}$$

$$C_{FF} = \frac{1}{2\pi \times (f_{C} \times \sqrt{(R_{FB1} \times (R_{FB1} /\!/ R_{FB2}))})}$$

As the internal RC compensation of the SiC431 works with a wide range of output LC filters, the SiC431 offers stable operation for a wide range of output capacitance, making the product versatile and usable in a wide range of applications.

#### **Input Capacitance**

In order to determine the minimum capacitance the input voltage ripple needs to be specified;  $V_{CINPKPK} \leq 500$  mV is a suitable starting point. This magnitude is determined by the final application specification. The input current needs to be determined for the lowest operating input voltage,

$$I_{\text{CIN}(\text{RMS})} = \\ I_{\text{O}} \times \sqrt{D \times (1 - D) + \frac{1}{12} \times \left(\frac{V_{\text{OUT}}}{L \times f_{\text{sw}} \times I_{\text{OUT}}}\right)^{2} \times (1 - D)^{2} \times D}}$$

The minimum input capacitance can then be found,

$$C_{IN\_min.} = I_{OUT} \times \frac{D \times (1 - D)}{V_{CINPKPK} \times f_{sw}}$$

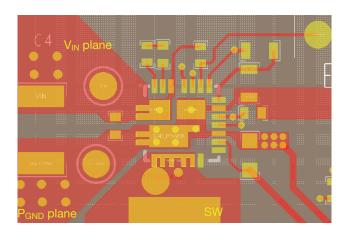
If high ESR capacitors are used, it is good practice to also add low ESR ceramic capacitance. A 4.7  $\mu$ F ceramic input capacitance is a suitable starting point.

Care must be taken to account for voltage derating of the capacitance when choosing an all ceramic input capacitance.



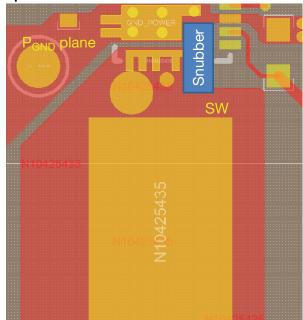
## **PCB LAYOUT RECOMMENDATIONS**

#### Step 1: V<sub>IN</sub>/GND Planes and Decoupling



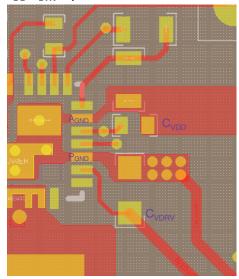
- 1. Layout  $V_{\text{IN}}$  and  $P_{\text{GND}}$  planes as shown above
- 2. Ceramic capacitors should be placed between  $V_{\text{IN}}$  and  $P_{\text{GND}}$ , and very close to the device for best decoupling effect
- Various ceramic capacitor values and package sizes should be used to cover entire decoupling spectrum e.g. 1210 and 0603
- 4. Smaller capacitance values, closer to  $V_{\text{IN}}$  pin(s), provide better high frequency response

Step 2: SW Plane



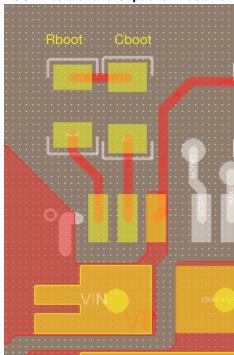
- 1. Connect output inductor to device with large plane to lower resistance
- 2. If a snubber network is required, place the components on the bottom layer as shown above

Step 3: V<sub>DD</sub>/V<sub>DRV</sub> Input Filter



- 1.  $C_{VDD}$  cap should be placed between  $V_{DD}$  and  $A_{GND}$  to achieve best noise filtering
- 2.  $C_{VDRV}$  cap should be placed close to  $V_{DRV}$  and  $P_{GND}$  pins to reduce effects of trace impedance and provide maximum instantaneous driver current for low side MOSFET during switching cycle

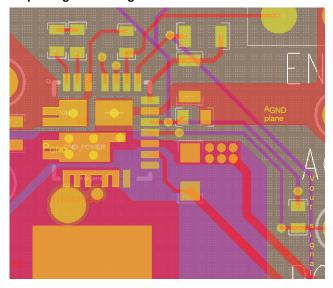
**Step 4: BOOT Resistor and Capacitor Placement** 



- C<sub>BOOT</sub> and R<sub>BOOT</sub> need to be placed very close to the device, between PHASE and BOOT pins
- In order to reduce parasitic inductance, it is recommended to use 0402 chip size for the resistor and the capacitor

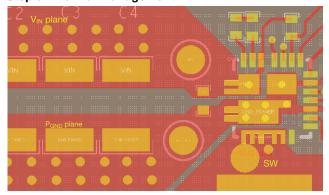


## Step 5: Signal Routing



- 1. Separate the small analog signal from high current path. As shown above, the high paths with high dv/dt, di/dt are placed on the left side of the IC, while the small control signals are placed on the right side of the IC. All the components for small analog signal should be placed closer to IC with minimum trace length
- 2. IC analog ground ( $A_{GND}$ ), pin 16, should have a single connection to  $P_{GND}$ . The  $A_{GND}$  ground plane connected to pin16 helps to keep  $A_{GND}$  quiet and improves noise immunity
- The output signal can be routed through inner layers.
   Make sure this signal is far away from SW node and shielded by an inner ground layer

### Step 6: Thermal Management

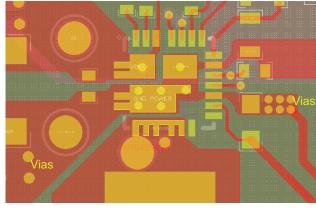


- 1. Thermal relief vias can be added to the  $V_{\text{IN}}$  and  $P_{\text{GND}}$  pads to utilize inner layers for high current and thermal dissipation
- 2. To achieve better thermal performance, additional vias can be placed on  $V_{\text{IN}}$  and  $P_{\text{GND}}$  planes. It is also necessary to duplicate the  $V_{\text{IN}}$  and ground plane at bottom layer to maximize the power dissipation capability of the PCB

## Vishay Siliconix

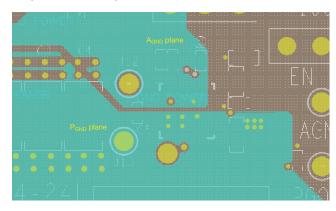
- SW pad is a noise source and it is not recommended to place vias on this pad
- 4. 8 mil vias on pads and 10 mil vias on planes are ideal via sizes. The vias on pad may drain solder during assembly and cause assembly issues. Please consult with the assembly house for guideline

## **Step 7: Ground Connection**



1. In order to minimize the ground voltage drop due to high current, it is recommended to place vias on the  $P_{\mathsf{GND}}$  planes. Make use of the inner ground layers to lower the impedance

### Step 7: Ground Layer



- 1. It is recommended to make the whole inner 1 layer (next to top layer) ground plane
- This ground plane provides shielding between noise source on top layer and signal trace within inner layer
- 3. The ground plane can be broken into two section,  $P_{GND}$  and  $A_{GND}$



# Vishay Siliconix

Part number	SiC437A	SiC437B	SiC437C	SiC437D
rait number	0.0.0	0.0.0.	0.0.00	0.0.0.
	12 A, 4.5 V to 28 V input, 300 kHz, 500 kHz,	12 A, 4.5 V to 28 V input, 300 kHz, 500 kHz,	12 A, 3 V to 28 V input, 300 kHz, 500 kHz,	12 A, 3 V to 28 V input, 300 kHz, 500 kHz,
	750 kHz, 1 MHz,			
Description	synchronous buck	synchronous buck	synchronous buck	synchronous buck
	regulator with	regulator with	regulator with	regulator with
	ultrasonic mode and internal 5 V bias	power save mode and internal 5 V bias	ultrasonic mode, requires external 5 V bias	power save mode, requires external 5 V bias
Input voltage min. (V)	4.5	4.5	3	3
Input voltage max. (V)	28	28	28	28
Output voltage min. (V)	0.6	0.6	0.6	0.6
Output voltage max. (V)	0.9 x V <sub>IN</sub>			
Continuous current (A)	12	12	12	12
Switch frequency min. (kHz)	300	300	300	300
. , , ,		1 1 1		
Switch frequency max. (kHz)	1000	1000	1000	1000
Pre-bias operation (yes / no)	Yes	Yes	Yes	Yes
Internal bias reg. (yes / no)	Yes	Yes	No	No
Compensation	Internal	Internal	Internal	Internal
Enable (yes / no)	Yes	Yes	Yes	Yes
P <sub>GOOD</sub> (yes / no)	Yes	Yes	Yes	Yes
Over current protection	Yes	Yes	Yes	Yes
Protection	OVP, OCP, UVP/SCP, OTP, UVLO			
Light load mode	Selectable ultrasonic	Selectable powersave	Selectable ultrasonic	Selectable powersave
Peak efficiency (%)	97	97	97	97
Package type	PowerPAK MLP44-24L	PowerPAK MLP44-24L	PowerPAK MLP44-24L	PowerPAK MLP44-24L
Package size (W, L, H) (mm)	4 x 4 x 0.75			
Status code	1	1	1	1
Product type	microBUCK (step down regulator)			
Applications	Computing, consumer, industrial, healthcare, networking			

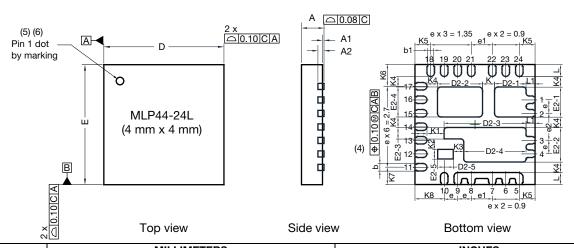
## Vishay Siliconix

PRODUCT SUMMARY	PRODUCT SUMMARY							
Part number	SiC438A	SiC438B	SiC438C	SiC438D				
Description	8 A, 4.5 V to 28 V input, 300 kHz, 500 kHz, 750 kHz, 1 MHz, synchronous buck regulator with ultrasonic mode and internal 5 V bias	8 A, 4.5 V to 28 V input, 300 kHz, 500 kHz, 750 kHz, 1 MHz, synchronous buck regulator with power save mode and internal 5 V bias	8 A, 3 V to 28 V input, 300 kHz, 500 kHz, 750 kHz, 1 MHz, synchronous buck regulator with ultrasonic mode, requires external 5 V bias	8 A, 3 V to 28 V input, 300 kHz, 500 kHz, 750 kHz, 1 MHz, synchronous buck regulator with power save mode, requires external 5 V bias				
Input voltage min. (V)	4.5	4.5	3	3				
Input voltage max. (V)	28	28	28	28				
Output voltage min. (V)	0.6	0.6	0.6	0.6				
Output voltage max. (V)	0.9 x V <sub>IN</sub>	0.9 x V <sub>IN</sub>	0.9 x V <sub>IN</sub>	0.9 x V <sub>IN</sub>				
Continuous current (A)	8	8	8	8				
Switch frequency min. (kHz)	300	300	300	300				
Switch frequency max. (kHz)	1000	1000	1000	1000				
Pre-bias operation (yes / no)	Yes	Yes	Yes	Yes				
Internal bias reg. (yes / no)	Yes	Yes	No	No				
Compensation	Internal	Internal	Internal	Internal				
Enable (yes / no)	Yes	Yes	Yes	Yes				
P <sub>GOOD</sub> (yes / no)	Yes	Yes	Yes	Yes				
Overcurrent protection	Yes	Yes	Yes	Yes				
Protection	OVP, OCP, UVP/SCP, OTP, UVLO	OVP, OCP, UVP/SCP, OTP, UVLO	OVP, OCP, UVP/SCP, OTP, UVLO	OVP, OCP, UVP/SCP, OTP, UVLO				
Light load mode	Selectable ultrasonic	Selectable powersave	Selectable ultrasonic	Selectable powersave				
Peak efficiency (%)	97	97	97	97				
Package type	PowerPAK MLP44-24L	PowerPAK MLP44-24L	PowerPAK MLP44-24L	PowerPAK MLP44-24L				
Package size (W, L, H) (mm)	4 x 4 x 0.75	4 x 4 x 0.75	4 x 4 x 0.75	4 x 4 x 0.75				
Status code	2	2	2	2				
Product type	microBUCK (step down regulator)	microBUCK (step down regulator)	microBUCK (step down regulator)	microBUCK (step down regulator)				
Applications	Computing, consumer, industrial, healthcare, networking	Computing, consumer, industrial, healthcare, networking	Computing, consumer, industrial, healthcare, networking	Computing, consumer, industrial, healthcare, networking				

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?75921">www.vishay.com/ppg?75921</a>.



# PowerPAK® MLP44-24L Case Outline



DIM.	MILLIMETERS			INCHES		
DIIVI.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A <sup>(8)</sup>	0.70	0.75	0.80	0.027	0.029	0.031
A1	0.00	-	0.05	0.000	-	0.002
A2		0.20 ref.			0.008 ref.	
b <sup>(4)</sup>	0.20	0.25	0.30	0.008	0.010	0.012
b1	0.15	0.20	0.25	0.006	0.008	0.010
D	3.90	4.00	4.10	0.155	0.157	0.159
е		0.45 BSC			0.018 BSC	
e1		0.70 BSC			0.028 BSC	
e2		0.90 BSC			0.035 BSC	
E	3.90	4.00	4.10	0.154	0.157	0.161
L	0.35	0.40	0.45	0.014	0.016	0.018
N <sup>(3)</sup>		24			24	
D2-1	1.00	1.05	1.10	0.039	0.041	0.043
D2-2	1.45	1.50	1.55	0.057	0.059	0.061
D2-3	2.68	2.73	2.78	0.106	0.108	0.110
D2-4	2.02	2.07	2.12	0.079	0.081	0.083
D2-5	0.47	0.52	0.57	0.018	0.020	0.022
E2-1	0.95	1.00	1.05	0.037	0.039	0.041
E2-2	1.10	1.15	1.20	0.043	0.045	0.047
E2-3	0.33	0.38	0.43	0.013	0.015	0.017
E2-4	0.95	1.00	1.05	0.037	0.039	0.041
E2-5	0.27	0.32	0.37	0.011	0.013	0.015
K		0.40 ref.			0.016 ref.	
K1		0.57 ref.			0.022 ref.	
K2		0.35 ref.			0.014 ref.	
K3		0.35 ref.			0.014 ref.	
K4		0.35 ref.			0.014 ref.	
K5	0.525 ref.			0.525 ref. 0.021 ref.		
K6	0.725 ref.				0.029 ref.	
K7	0.575 ref. 0.023 ref.					
K8		0.975 ref.		0.038 ref.		
ECN: T17-0551-F DWG: 6055	Rev. B, 16-Oct-17					

## Notes

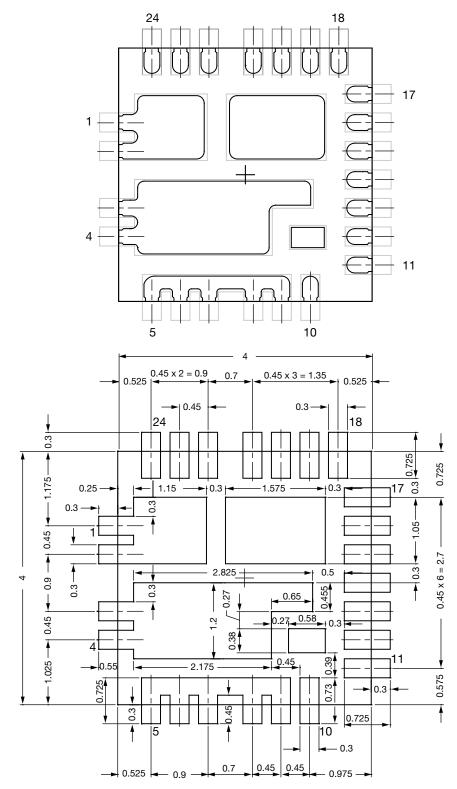
- Use millimeters as the primary measurement
  Dimensioning and tolerances conform to ASME Y14.5M. 1994
- N is the number of terminals
- Dimension b applies to plated terminal and is measured between 0.20 mm and 0.25 mm from terminal tip
  The pin #1 identifier must be existed on the top surface of the package by using indentation mark or other feature of package body
  Exact shape and size of this feature is optional
- Package warpage max. 0.08 mm Applied only for terminals

Revision: 16-Oct-17

Document Number: 74345



## Recommended Land Pattern PowerPAK® MLP44-24L



All dimensions are in millimeters



## **Legal Disclaimer Notice**

Vishay

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